TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL PLANAR TYPE

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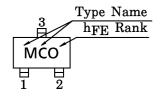
VHF~UHF BAND LOW NOISE AMPLIFIER APPLICATIONS

- Low Noise Figure, High Gain.
- NF=1.1dB, $|S_{21e}|^2 = 11dB$ (f=1GHz)

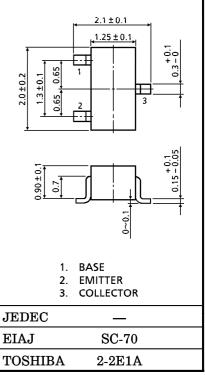
MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	v_{CBO}	20	V
Collector-Emitter Voltage	v_{CEO}	12	V
Emitter-Base Voltage	$V_{ m EBO}$	3	V
Base Current	$I_{\mathbf{B}}$	40	mA
Collector Current	$^{\mathrm{I}}\mathrm{C}$	80	mA
Collector Power Dissipation	$P_{\mathbf{C}}$	100	mW
Junction Temperature	T_{j}	125	°C
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~125	°C

MARKING



Unit in mm



Weight: 0.006g

MICROWAVE CHARACTERISTICS (Ta = 25°C)

	•	•				
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Transition Frequency	$ m f_{T}$	$V_{CE}=10V, I_{C}=20mA$	5	7	_	GHz
Insertion Gain	$ S_{21e} ^2$ (1)	$V_{CE} = 10V, I_{C} = 20mA, f = 500MHz$	_	16.5	_	dB
	$ S_{21e} ^2$ (2)	V_{CE} =10V, I_{C} =20mA, f =1GHz	7.5	11	_	uD
Noise Figure	NF (1)	$V_{CE}=10V$, $I_{C}=5mA$, $f=500MHz$	_	1	_	dB
	NF (2)	$V_{CE}=10V$, $I_{C}=5mA$, $f=1GHz$	_	1.1	2	ub

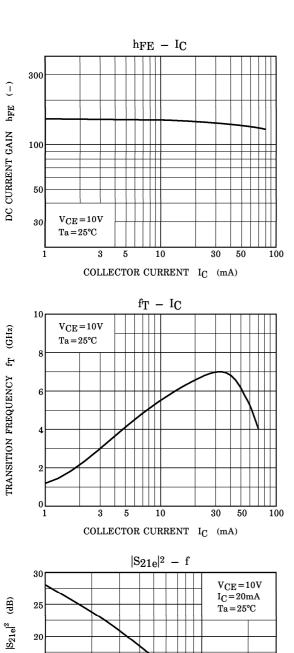
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

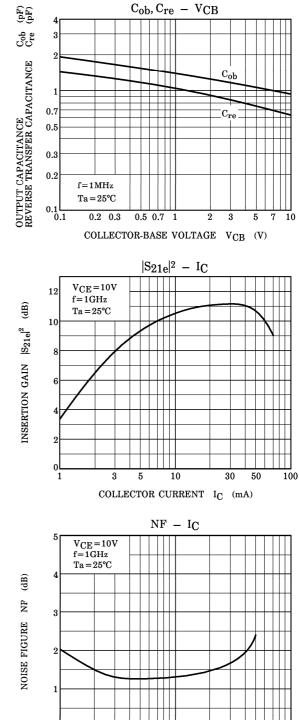
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	I_{CBO}	$V_{CB} = 10V, I_{E} = 0$		_	1	μ A
Emitter Cut-off Current	I_{EBO}	$V_{EB}=1V, I_{C}=0$	_	_	1	μ A
DC Current Gain	hFE (Note 1)	$V_{CE} = 10V, I_{C} = 20mA$	80	_	240	—
Output Capacitance	$C_{f ob}$	$V_{CB} = 10V, I_{E} = 0, f = 1MHz$		1.0	_	pF
Reverse Transfer Capacitance	$\mathrm{c_{re}}$	(Note 2)	_	0.65	1.15	рF

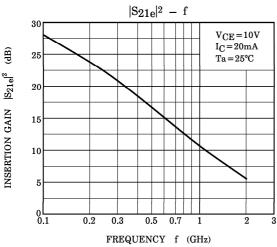
(Note 1) $h_{\mbox{\scriptsize FE}}$ Classification $O:80{\sim}160, Y:120{\sim}240$

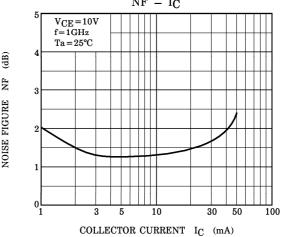
(Note 2) Cre is measured by 3 terminal method with capacitance bridge.

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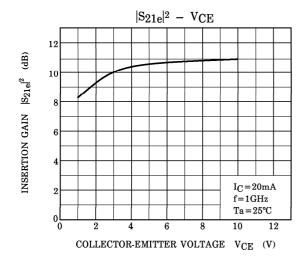


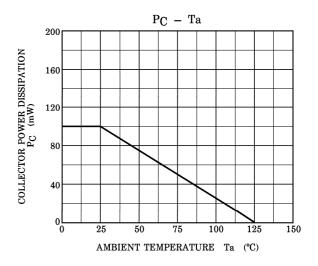






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S-Parameter $Z_O = 50\Omega$, $Ta = 25^{\circ}C$ $V_{CE} = 10V$, $I_C = 5mA$

frequency S11		11	S21		S12		S22	
(MHz)	Mag.	Ang.	Mag.	Ang.	Mag.	Ang.	Mag.	Ang.
200	0.672	-73.0	9.460	128.6	0.052	53.6	0.707	-31.3
400	0.498	-115.9	6.268	105.9	0.068	46.8	0.513	-36.2
600	0.443	-141.7	4.554	93.3	0.078	49.0	0.437	-36.6
800	0.426	-158.7	3.556	84.5	0.088	53.2	0.401	-36.8
1000	0.422	-171.9	2.948	77.5	0.099	57.9	0.383	-38.3
1200	0.428	177.5	2.526	71.1	0.113	62.7	0.373	-40.6
1400	0.437	168.3	2.240	65.5	0.133	65.8	0.367	-43.9
1600	0.449	159.9	1.997	60.1	0.152	67.6	0.362	-48.2
1800	0.464	153.1	1.821	55.0	0.171	68.7	0.358	-52.8
2000	0.485	146.7	1.686	50.9	0.195	70.6	0.350	-57.6

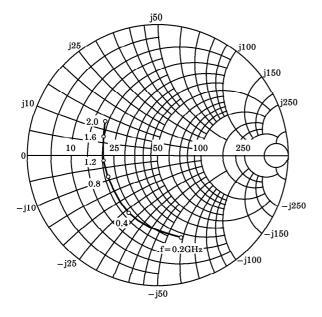
$V_{CE} = 10V, I_{C} = 20mA$

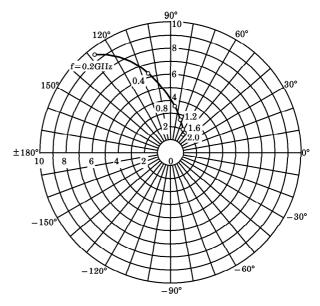
frequency	S11		S21		S12		S22	
(MHz)	Mag.	Ang.	Mag.	Ang.	Mag.	Ang.	Mag.	Ang.
200	0.392	-116.4	16.247	109.3	0.034	59.7	0.420	-43.7
400	0.329	-152.1	8.775	94.5	0.054	66.0	0.280	-38.4
600	0.321	-170.6	6.018	86.3	0.075	69.5	0.244	-33.7
800	0.321	177.5	4.598	80.2	0.097	70.7	0.231	-31.7
1000	0.324	167.9	3.767	74.8	0.119	71.2	0.225	-31.3
1200	0.332	160.3	3.191	70.0	0.142	71.3	0.225	-32.7
1400	0.341	153.5	2.812	65.2	0.168	70.0	0.225	-36.2
1600	0.352	146.6	2.502	60.7	0.190	68.4	0.222	-40.3
1800	0.362	142.2	2.264	56.5	0.212	66.8	0.217	-44.9
2000	0.379	137.7	2.092	52.8	0.236	66.3	0.212	- 49.4

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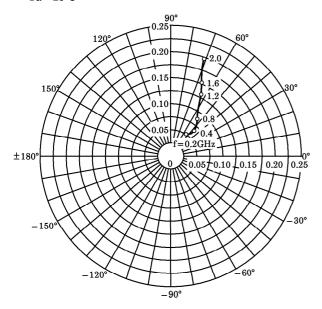
 $\begin{array}{l} S_{11e} \\ V_{CE} = 10V \\ I_{C} = 5 mA \\ Ta = 25 ^{\circ}C \\ (UNIT:\Omega) \end{array}$



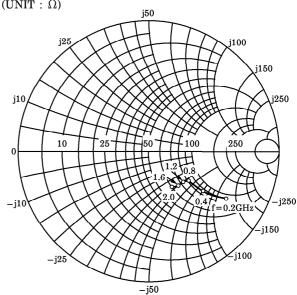




 $\begin{array}{l} S_{12e} \\ V_{CE} = 10V \\ I_{C} = 5 \text{mA} \\ Ta = 25 ^{\circ}\text{C} \end{array}$

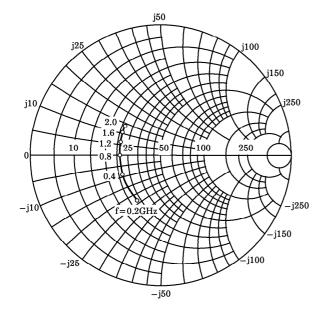


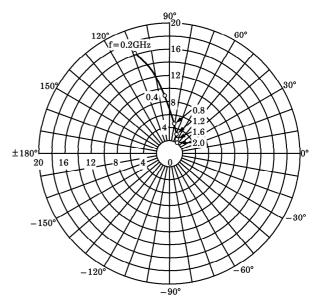




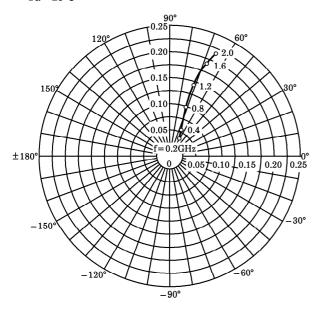
 $\begin{array}{l} S_{11e} \\ V_{CE} \! = \! 10V \\ I_{C} \! = \! 20\text{mA} \\ T_{a} \! = \! 25^{\circ}\! C \\ (UNIT:\Omega) \end{array}$







 $\begin{array}{l} {\rm S}_{12e} \\ {\rm V}_{CE} \! = \! 10{\rm V} \\ {\rm I}_{C} \! = \! 20{\rm mA} \\ {\rm Ta} \! = \! 25^{\circ}\!{\rm C} \end{array}$



 $\begin{array}{c} S_{22e} \\ V_{CE} = 10V \\ I_{C} = 20 mA \\ T_{a} = 25 ^{\circ} C \\ (UNIT: \Omega) \\ \\ j_{10} \\ j_{25} \\ j_{10} \\ j_$

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